

# *Notice of References Cited*

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
TAKAHASHI ET AL.

Examiner

Paul Marcantoni

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## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0052307	12-2001	Pye et al.	106/717
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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## NON-PATENT DOCUMENTS

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	U	JP 02002242118 A (OGAWA et al.) 8-2002.
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